

Implementation and performance of ALTIROC3 readout ASIC for the ATLAS HGTD timing detector

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ALTAS HGTD

- With the high-luminosity environment of the HL-LHC comes increased pileup making event discrimination more challenging.
- High-precision timing measurements can be used to improve pile-up rejection when combined with Inner Tracker (ITk) position data.
- The High-Granularity Timing Detector for ATLAS aims to provide :
 - Timing information with 30-50 ps per track (35-70 ps per hit) resolution over full lifetime
 - Luminosity information by reading hit counts for each bunch crossing
- Two endcaps located between the barrel and the calorimeters
 - Located at 3.5 m from the interaction point
 - Two double-sided disks per endcap
 - Active radius from 120 mm to 640 mm
 - Each disk is segmented into three rings of modules with different sensor overlaps 70%, 54%, 20% overlap for inner, middle and outer rings



Modules

- A module is composed of two ALTIROC ASICs bump bonded onto two 15x15 LGAD sensors (hybrids)
- 8032 modules with 3.6 M channels in total
- 2 × 4 cm² modules, 450 pixels per module
- Wire Bonding I/O PADs for all other signals and power supplies
- ASIC in contact with the cooling plate (-30 °C)
- Connection to peripheral electronics with a flex PCB
- → Power supplies only from one side, voltage drop control is a key issue













ALTIROC overview

- Technology: 130 nm 1.2 V CMOS TSMC
- ASIC size:

Pixel area: 19.5 x 19. 5 mm² Total area: 22 x 20 mm²

• Pixel area:

15 x 15 pixel matrix

Pixel size: 1.3 x 1.3 mm²

• On-pixel electronics:

Analog: preamp + discriminator + 2 TDCs (TOA and TOT)

Digital: primary buffer (SRAM) to cope with latencies up to 38 µs, zero suppression, and secondary buffer to keep data after zero suppression

• Periphery composed of slow and fast interfaces, clocks control, bandgap, PLL, phase shifter, bias block...



Verification of ALTIROC performances with IRDrop analyses

- ALTIROC is a large chip (>4cm²) and only powered from the bottom
- Voltage drops can be critical in such chips as they can drastically degrade performance of the detector (minimum threshold, timing resolution)
- Main checks to do at chip level :
 - Limit dynamic digital voltage drop to limit noise that can impact analog front-end
 - Limit voltage drops of analog front-end power domains (especially TDCs)
- ALTIROC is designed digital-on-top, which makes full chip verifications a lot easier :
 - Characterization of macros blocks designed with Virtuoso using Power Grid View (PGV)
 - Use Voltus for IRDrop analyses



Power Grid View generation for a macro block



- SRAM (Custom block developed in Virtuoso) :
 - Same power domain as digital part
 - Power must be considered for digital IRDrop analysis
- Power Grid Views are generated to accurately capture the current and capacitance distribution inside a macro block :
- → Post layout simulation using spectre (EMIR flow) Current profile

Accurate current distribution inside the block

→ Abstract view

Power Grid information

→ Trigger file

When to start current waveform during IRDrop analysis



Full chip digital IRDrop analysis

- Integration of SRAM Power Grid View in Voltus flow
- IRDrop analysis uses activity file from digital simulations for its power analysis
 - Accurate activity for all standard cells
 - Trigger the current profile for each SRAM
- Several simulations to test worst possible cases
 - Broadcast I2C
 - Global reset
 - High occupancy + trigger in same bunch crossing
- Corner used is : FF, 1.32 V, -40 °C
- These simulations are really useful to fix local drops, especially in sensitive areas with large buffers
- ~50 mV drop for VDD and GND
 - Specification for this technology is <90 mV for VDD and GND



Full Chip digital voltage drop (high occupancy + trigger)







TDC performance issue

- During ALTIROC2 tests, we observed degraded performance of the TDCs inside each pixel when increasing hit occupancy
 - Pixels impact their neighbors when receiving a hit
 - Unstable TDC bin for different hit pattern ۰
 - Identification of voltage drops as main contributor ٠
- For ALTIROC3 the idea of implementing independent power routing for each TDC of each pixel was proposed :
 - Same resistance of power rail for each pixel ۲
 - One PAD per power per column
- This solution uses more space, tradeoff between power domains must be considered

It was mandatory to verify the impact and the effectiveness of this solution with **IRDrop** analyses



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binning (ps) 52

TOA TDC's quantize

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Setting up Power Grid View for the analog IRDrop

- Same flow as presented before to setup analog front-end Power Grid View : **TDC (TOA)**, TDC (TOT), Discri, Preamp
- One PGV for the analog front-end
 - Spectre simulation of the full chain (preamplifier, discriminator, TDCs)
 - Include power routing of all the different power domains
 - Trigger used is the signal starting the charge injection
- Run a digital simulation that sends this signal to all the pixels
 - → Generate an activity file
- Both analog PGV and activity files are used to run a full-chip IRDrop analysis



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Voltage drop TDC TOA

Full chip analog IRDrop analysis

- Aggressive simulation in order to test the worst case (100 % occupancy)
- TDC can cope with reasonnable voltage drops, but the drop must be stable ۲
 - The goal is to have the lowest drop possible while having similar drop for each pixel
- Validate that power routing is not missing any ٠ connections as it is done manually
- Keep improving this power routing between ALTIROC3 and pre-production chip ALTIROCA
- → Balance PADs positions for VDD/GND to remove discrepancies between columns



ALTIROC3 TOA domain based ~45mV difference, 129mV worst drop





Independent power routing effectiveness

- Independent power routing implemented in ALTIROC3 is very effective but performance could still be improved
- Two other effects were observed :
 - Voltage drops on wirebonds effect
 - Need to reduce wirebond resistance
 - Try to reduce length as much as possible
 - Effect is very linear so offline correction should be possible if needed
 - Noisy signal coupling with one of the bias of the TDC
 - Shield between the two but large filling above
 - Tested with a Focused Ion Beam to physically cut the line
 - Signal removed in ALTIROCA





Hybrid Performances – Efficiency

- Hybrid is ASIC + LGAD sensor
- S-curve for the 225 channels are obtained from a charge scan
- The threshold is defined as the charge value at 95 % efficiency
- Minimum detectable charge *Qmin* is close to 2.5 fC in average







Hybrid Performances in testbeam - Resolution

- Correlation between the TOA measured by ALTIROC3+LGAD (X axis) and TOA measured by a reference Micro-Channel Plate (Y axis)
- The timing resolution of 45.8 ps is obtained with time walk correction (tests are done at room temperature)





Conclusion

- Power Grid Views and Voltus are very convenient to run full-chip IRDrop analyses on analog blocks designed in Virtuoso
- Power Grid View generation can be difficult to setup the first time

→ Thanks to CHIPS initiative at CERN and microelectronics team for their help and tutorials !
→ I wrote some documentation with tips and solutions to frequent issues for abstract/PGV generation and IRDrop analyses, feel free to contact me if you need them

- ALTIROC3 ASIC is functional and meeting specifications
- Hybrid measurements:
 - Promising results with ALTIROC3 in testbeam
 - First hybrids with ALTIROCA are being characterized at testbeam
 - Full module testing coming soon



Thank you







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Backup





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Full chip analog IRDrop analysis – Realistic case

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- Can use trigger of the PGV for simulating more realistic cases
- Trigger take into account the enable signal of the TDC
- Simulated with 10% occupancy

- It is also possible to add RLC values to each voltage source for example to take wirebond into account
 - → set_rail_analysis_config -default_package_resistor -default_package_capacitor -default_package_inductor







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Full chip TOA IRDrop analysis







ALTIROC2 TDC voltage drop analysis



- Analysis done post foundry
- Agressive simulation/corner showed here, all the pixel's TDCs are triggered
- Issues observed in Altiroc2 :
- → High voltage drops on TDCs
- ➔ Drops depend on the activity
- → TDC LSB is different depending on the number of pixel receiving a hit (impossible to tune)





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TOA TDC Architecture (simplified): Vernier Delay Line



- The **START** pulse comes first and initializes the TDC operation
- The **STOP** pulse follows the **START** with a delay that represents the time interval to be digitalized
- At each tap of the Delay Line the **STOP** signal catches up to the **START** signal by the difference of the propagation delays of cells in Slow and Fast branches of the delay line i.e. **140ps 120ps = 20 ps** that represents the LSB of time measurement
- The number of cells necessary for STOP signal to surpass the START signal represents the result of TDC conversion
- TDC range is equal to 128*20ps=2.56 ns



ALTIROC3 power routing

- Implementation of independent power routing for each TDC of each pixel in Altiroc3
- Adjust width of M7 to control Resistance of each power line
- Independent power routing has been done manually in innovus at column level (now included in scripts)
- This new power routing is wider than before and impact digital power routing

End of Column :



Crosstalk between vctrl and toa_busy

- Noisy signal coupling with one of the bias of the TDC
- Vctrl is one of the bias of TOA TDC
- Toa_busy is a debug signal (not possible to disable)
- Shield done using gndd, width/spacing was quite small
- This bias is a sensitive signal
- These lines are in parallel for 15x2cm
- Filling is done using scripts
 - It is possible to remove filling from some area but we didn't see the issue early enough
- FIB (Focused Ion Beam) was done to cut the toa_busy in several columns (SERMA company)
 - → Effect completely removed for these columns









ASIC Specification

Charge dynamics : up to 100 fCNoise: < 0.5 fC</td>Cross talk: < 2 % to guarantee single
hit with 2 fC threshold

TOA :

Measurement window 2.5 ns Jitter : 25 ps for Q = 10 fC 65 ps for Q = 4 fC Conversion time < 25 ns (TDC LSB of 20 ps)

TOT :

For 100 fC, TOT < 20 ns

	4.50	× 10.fC
Landau MPV	410	> 10 10
Time Walk contribution rms (ps)	25	10
TOT resolution for VPA (ps)	120	120
TOT resolution for TZ (ps)	120	70

Conversion time < 25 ns TDC LSB of 120 ps enough but TZ better use with 40 ps

40 MHz Clock of the TDC :

Jitter < 10 ps ASIC global clock aligned with better than 100 ps Clock skew between channels in ASIC : +/- 150 ps

Luminosity

Provide ASIC number of hits per bunch crossing on two time windows Similar alignment as for the clock but skew relaxed to +/- 200 ps

Read out bandwidth and latency :

Should cope with 1 MHz with 12.8 μ s and 0.8 MHz with 35 μ s ASIC bandwidth adjustable by slow control : 0.32, 0.64 or 1.28 Gb/s

Radiation		TID [MGy]		NIEL [$n_{\rm eq}$ /cm ²]		SEE [<i>h</i> /cm ²]	
tolerance :	ASIC Barrel	2.0	(2.25)	2.5×10^{15}	(1.5)	$1. \times 10^{15}$	(1.5)

ASIC power dissipation < 1.2 W

Calibration injection : Range 0 – 100 fC Rise time : 0.5-1.5 ns





Hybrid Performances – Jitter

- Mean jitter across all channels as function of charge with a threshold of ~5 fC for different boards with ALTIROC3
- The temperature shown in the figure is the temperature inside the climate chamber
 - \rightarrow At -40°C the temperature of the hybrid is around -30°C
- Jitter increase close to the charge used for threshold alignment is caused by the lower pulse slope on top of the pulse



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ASIC Performances – TID

- Mean Time Of Arrival (TOA) jitter for 4 and 10 fC injected charges versus total ionizing dose for **ALTIROC2** ASIC alone showing stability under radiation up to 220 Mrad.
- Dose rate : 3 Mrad/h Temperature : 22°C
- Jitter stays stable with the increasing Total Ionising dose





ASIC Performances – SEE

- Two main goals :
 - Prove the effectiveness of the triplication
 - Show a limited number of data frames corrupted
- Two campaigns in two different facilities (CAL at Nice and ARRONAX at Nantes)
 - Use of 65 MeV proton beam to realize irradiation test
- Counters implemented inside ASIC to count single errors in triplicated registers
- Expected erroneous registers at HL-LHC : no error expected on the configuration registers
- Erroneous timing at HL-LHC : 5x10⁻⁹% of data frames

